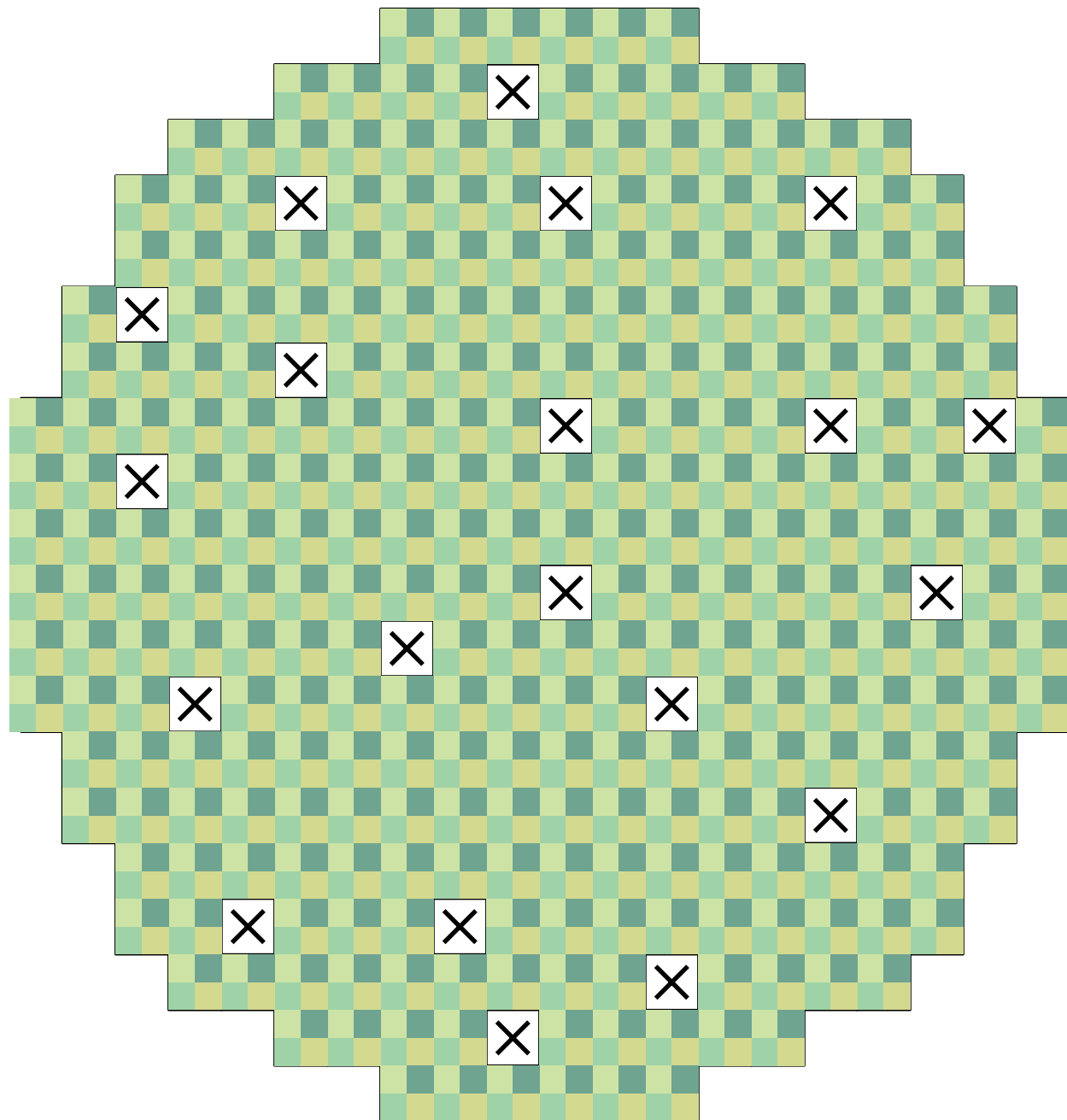


 Die × Measured die



Dies on the wafer:
 $n_d = 316$

Measured dies:
 $n'_d = 20$

Processing elements
on a die:
 $n_p = 4$

Measured processing
elements on a die:
 $n'_p = 4$